

**Search Notes**

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Examiner

Shew-Fen Lin

Applicant(s)/Patent under  
Reexamination

CORNWELL ET AL.

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
707	1-10	10/20/2006	SFL
707	200-205	10/20/2006	SFL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (US-PUB, USPAT, USOCR, EPO, JPO, IBM-TDB)	10/20/2006	SFL